

## General Description

SFGMOS<sup>®</sup>

$R_{DS(ON)}$ , low gate charge, fast switching and excellent avalanche characteristics. The low  $V_{th}$  series

**Absolute Maximum Ratings** at  $T_j=25^\circ\text{C}$  unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	100	V
Gate-source voltage	$V_{GS}$	$\pm 20$	V
Continuous drain current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_D$	55	A
Pulsed drain current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{D,\text{pulse}}$	165	A
Continuous diode forward current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_S$	55	A
Diode pulsed current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{S,\text{pulse}}$	165	A
Power dissipation <sup>3)</sup> , $T_C=25^\circ\text{C}$	$P_D$	115	W
Single pulsed avalanche energy <sup>5)</sup>	$E_{AS}$	14	mJ
Operation and storage temperature	$T_{stg}, T_j$	-55 to 150	$^\circ\text{C}$

**Thermal Characteristics**

Parameter	Symbol	Value	Unit
Thermal resistance, junction-case	$R_{\theta C}$	1.09	$^\circ\text{C}/\text{W}$
Thermal resistance, junction-ambient <sup>4)</sup>	$R_\theta$	62	$^\circ\text{C}/\text{W}$

**Electrical Characteristics** at  $T_j=25^\circ\text{C}$  unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	$BV_{DSS}$	100			V	$V_{GS}=0 \text{ V}, I_D=250 \text{ A}$
Gate threshold voltage	$V_{GS(\text{th})}$	1.5		2.5	V	$V_{DS}=V_{GS}, I_D=250 \text{ A}$
Drain-source on-state resistance	$R_{DS(\text{ON})}$		10	12		$V_{GS}=10 \text{ V}, I_D=30 \text{ A}$
Drain-source on-state resistance	$R_{DS(\text{ON})}$		12	15		$V_{GS}=4.5 \text{ V}, I_D=12 \text{ A}$
Gate-source leakage current	$I_{GSS}$			100	nA	$V_{GS}=20 \text{ V}$
				-100		$V_{GS}=-20 \text{ V}$
Drain-source leakage current	$I_{DSS}$			1	A	$V_{DS}=100 \text{ V}, V_{GS}=0 \text{ V}$
Gate resistance	$R_G$		3			1 ,

### Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	$C_{iss}$		1575		pF	$V_{GS}=0\text{ V}$ , $V_{DS}=25\text{ V}$ , 100 kHz
Output capacitance	$C_{oss}$		683		pF	
Reverse transfer capacitance	$C_{rss}$		68		pF	
Turn-on delay time	$t_{d(on)}$		16		ns	$V_{GS}=10\text{ V}$ , $V_{DS}=50\text{ V}$ , $R_G=2\text{ }\Omega$ , $I_D=25\text{ A}$
Rise time	$t_r$		4		ns	
Turn-off delay time	$t_{d(off)}$		35.6		ns	
Fall time	$t_f$		5.8		ns	

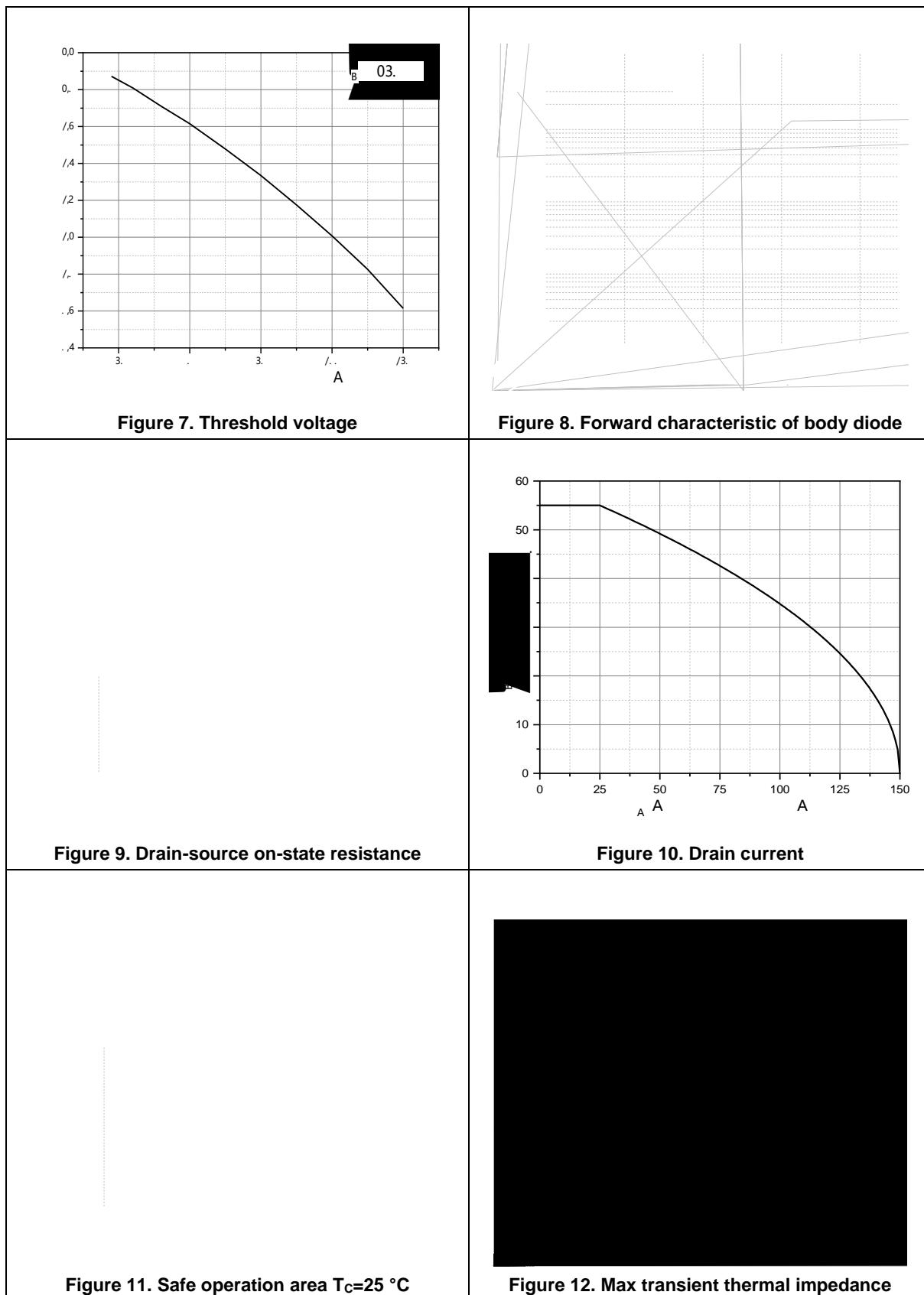
### Gate Charge Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Total gate charge	$Q_g$		24.6		nC	$V_{GS}=10\text{ V}$ , $V_{DS}=50\text{ V}$ , $I_D=25\text{ A}$
Gate-source charge	$Q_{gs}$		4.1		nC	
Gate-drain charge	$Q_{gd}$		5.8		nC	
Gate plateau voltage	$V_{plateau}$		3.1		V	

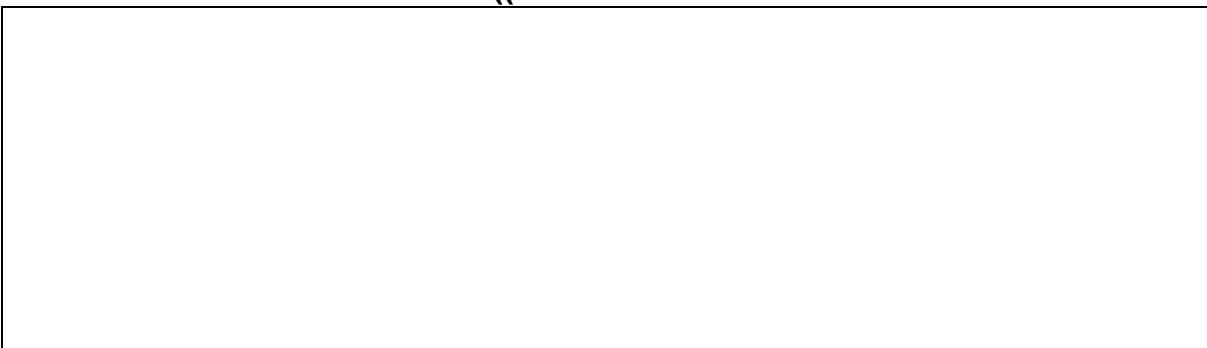
### Body Diode Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Diode forward voltage	$V_{SD}$			1.3	V	$I_S=30\text{ A}$ , $V_{GS}=0\text{ V}$
Reverse recovery time	$t_{rr}$		53.2		ns	$V_R=50\text{ V}$ , $I_S=25\text{ A}$ , / 100 /

**SFG10S12DF**



**Test circuits and waveforms rM7((rMe..584 594.31 0.48 0.48 ref70.584 594.31 ef0.48 ref831 439**

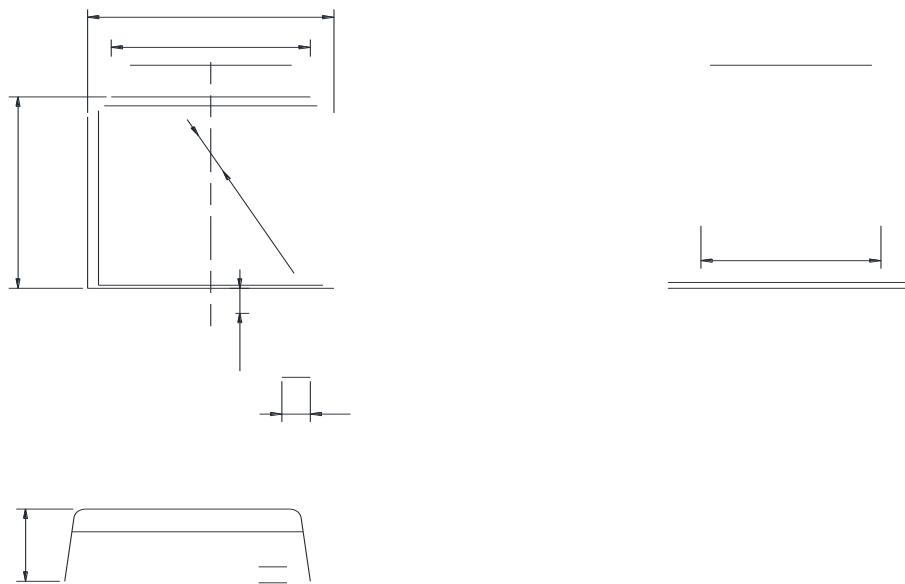


**Figure 1. Gate charge test circuit & waveform**



**Figure 2. Switching time test circuit & waveforms**

### Package Information



Symbol	mm		
	Min	Nom	Max
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.90	1.01	1.10
b	0.72	-	0.85
b1	0.71	0.76	0.81
b2	0.72	-	0.90
b3	5.13	5.33	5.46
c	0.47	-	0.60
c1	0.46	0.51	0.56
c2	0.47	-	0.60
D	6.00	6.10	6.20
D1	5.25	-	-
E	6.50	6.60	6.70
E1	4.70	-	-
e	2.186	2.286	2.386
H	9.80	10.10	10.40
L	1.40	1.50	1.70
L1	2.90 REF		
L2	0.508 BSC		
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	0.15	-	0.75
L6	1.80 REF		
θ	0	-	
θ1			
θ2			

Version 1:TO252-J package outline dimension

## Ordering Information

Package Type	Units/Reel	Reels/Inner Box	Units/Inner Box	Inner Box/Carton Box	Units/Carton Box
TO252	2500	2	5000	5	25000

## Product Information

Product	Package	Pb Free	RoHS	Halogen Free
SFG10S12DF	TO252	yes	yes	yes

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